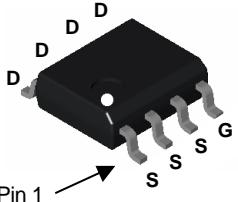
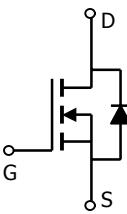
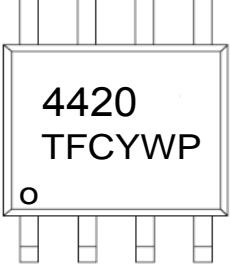


SOP-8 Plastic-Encapsulate MOSFETS

4420

N-Channel Enhancement Mode Power MOSFET

<p>Description</p> <p>The 4420 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge . The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.</p> <p>General Features</p> <table border="1" data-bbox="219 772 720 1012"> <thead> <tr> <th colspan="3">PRODUCT SUMMARY</th> </tr> <tr> <th>V_{DSS}</th><th>I_D</th><th>R_{DS(on)} (mΩ) Max</th></tr> </thead> <tbody> <tr> <td rowspan="2">30V</td><td>12 A</td><td>10.5 @ V_{GS} = 10V</td></tr> <tr> <td>8 A</td><td>12.0 @ V_{GS} = 4.5V</td></tr> </tbody> </table> <ul style="list-style-type: none"> ● High power and current handing capability ● Lead free product is acquired ● Surface mount package 	PRODUCT SUMMARY			V _{DSS}	I _D	R _{DS(on)} (mΩ) Max	30V	12 A	10.5 @ V _{GS} = 10V	8 A	12.0 @ V _{GS} = 4.5V	<p>SO-8L</p>  <p>Equivalent Circuit</p>  <p>MARKING</p>  <p>Y :year code W :week code</p>
PRODUCT SUMMARY												
V _{DSS}	I _D	R _{DS(on)} (mΩ) Max										
30V	12 A	10.5 @ V _{GS} = 10V										
	8 A	12.0 @ V _{GS} = 4.5V										

Absolute Maximum Ratings T_A=25°C unless otherwise noted				
Parameter	Symbol	Maximum	Units	
Drain-Source Voltage	V _{DS}	30	V	
Gate-Source Voltage	V _{GS}	±12	V	
Continuous Drain Current ^A	I _D	12	A	
Pulsed Drain Current ^B	I _{DM}	45		
Power Dissipation ^A	P _D	3.0	W	
		1.8		
Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics				
Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	t ≤ 10s	R _{0JA}	28	°C/W
			54	°C/W
Maximum Junction-to-Lead ^C	Steady-State	R _{0JL}	21	°C/W



SHENZHEN TUOFENG SEMICONDUCTOR TECHNOLOGY CO.,LTD

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Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS}=0\text{V}$	30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$			500	nA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$			± 100	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.6	1.1	2.0	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$			45	A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=12\text{A}$		8.3	10.5	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=8\text{A}$		9.7	12.0	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=15\text{V}, I_D=12\text{A}$		9		S
V_{SD}	Diode Forward Voltage	$I_S=3\text{A}, V_{GS}=0\text{V}$		0.76	1.0	V
I_S	Maximum Body-Diode Continuous Current				5	A

DYNAMIC PARAMETERS

C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$		3656		pF
C_{oss}	Output Capacitance			256		pF
C_{rss}	Reverse Transfer Capacitance			168		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$			1.1	Ω

SWITCHING PARAMETERS

$Q_g(10\text{V})$	Total Gate Charge (10V)	$V_{DD}=15\text{V}, V_{GEN}=4.5\text{V}, I_D=12\text{A}$		30.5		nC
$Q_g(4.5\text{V})$	Total Gate Charge (4.5V)			23		nC
Q_{gs}	Gate Source Charge			4.6		nC
Q_{gd}	Gate Drain Charge			8.6		nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{DD}=15\text{V}, V_{GEN}=10\text{V}, R_L=1.1\Omega$		5.5		ns
t_r	Turn-On Rise Time			3.4		ns
$t_{D(\text{off})}$	Turn-Off Delay Time	$R_{\text{GEN}}=3\Omega, I_D=12\text{A}$		49		ns
t_f	Turn-Off Fall Time			5.9		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=10\text{A}, dI/dt=100\text{A}/\mu\text{s}$		22		ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=10\text{A}, dI/dt=100\text{A}/\mu\text{s}$		12.5		nC

A: The value of R_{0JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R_{0JA} is the sum of the thermal impedance from junction to lead R_{0JL} and lead to ambient.

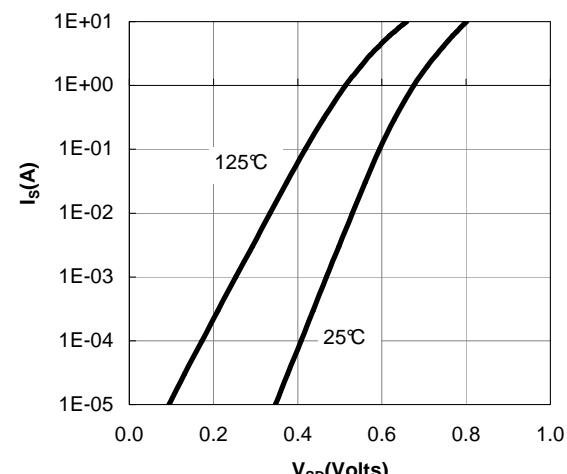
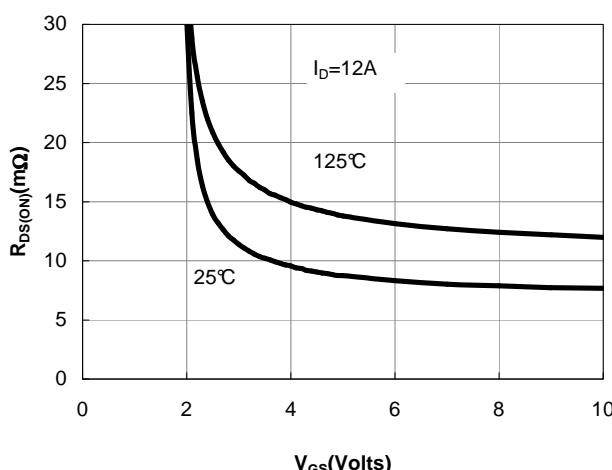
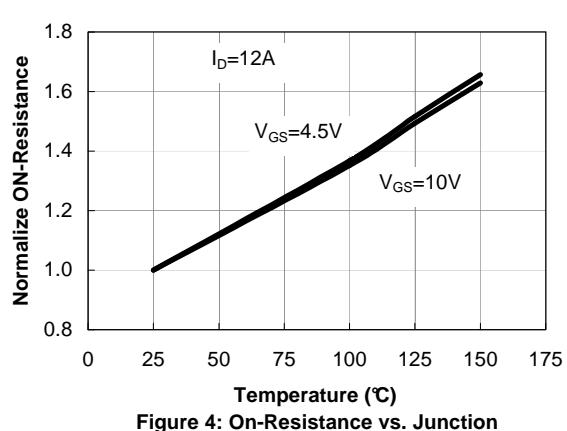
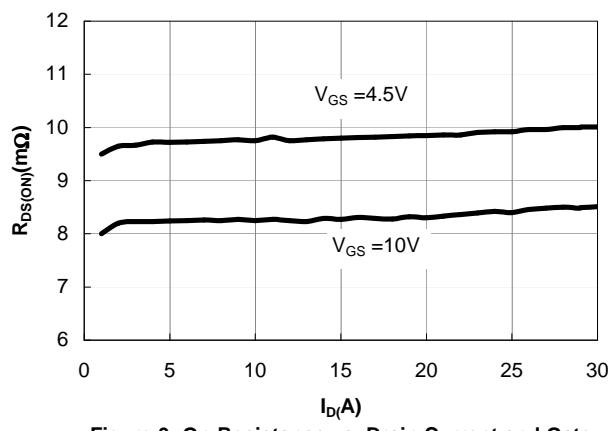
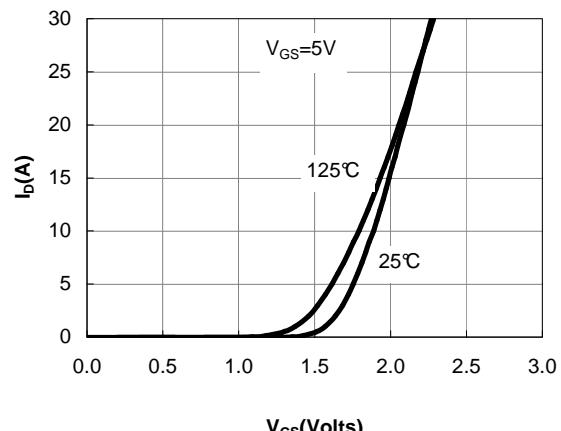
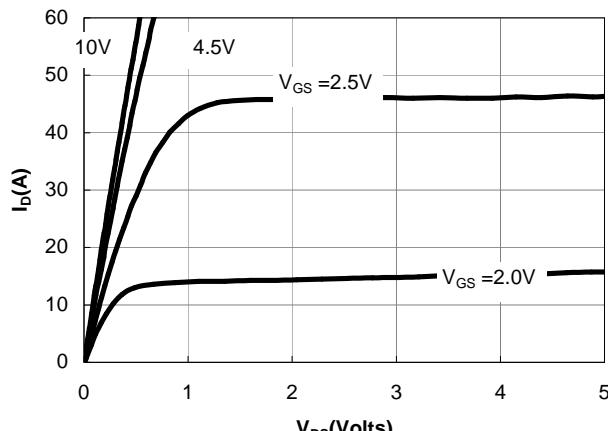
D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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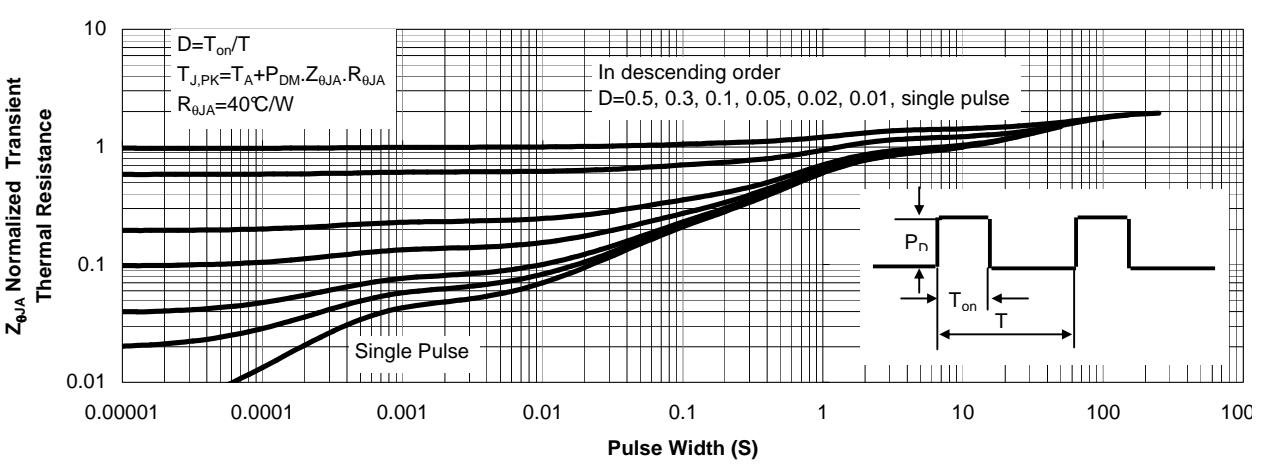
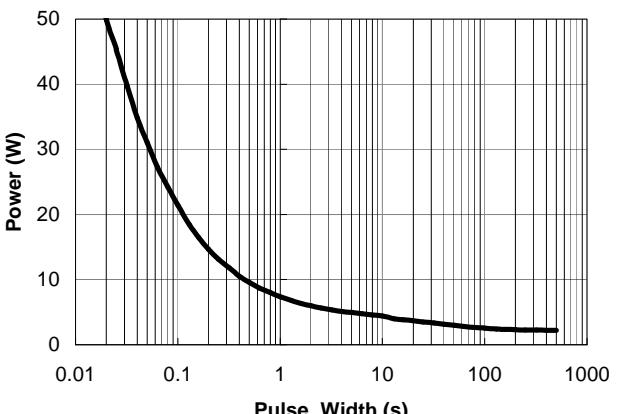
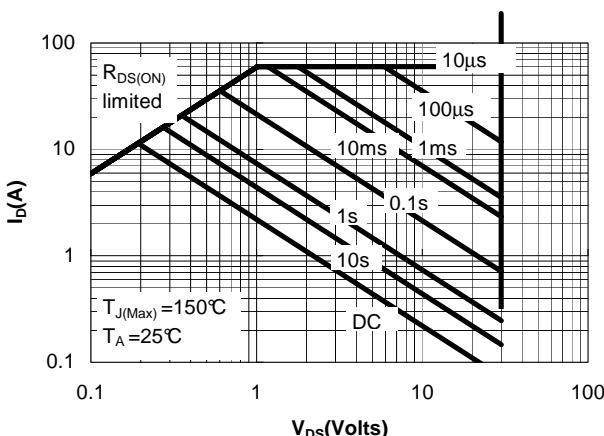
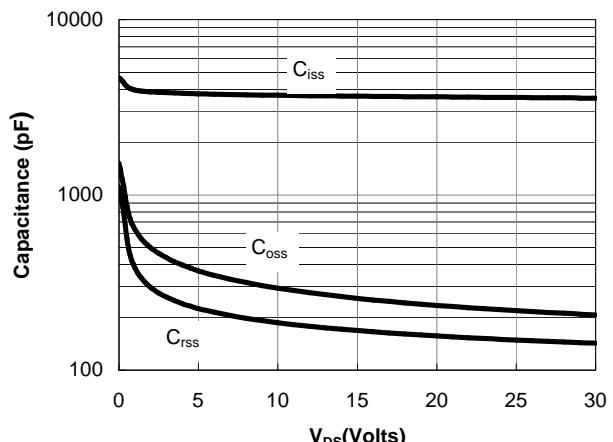
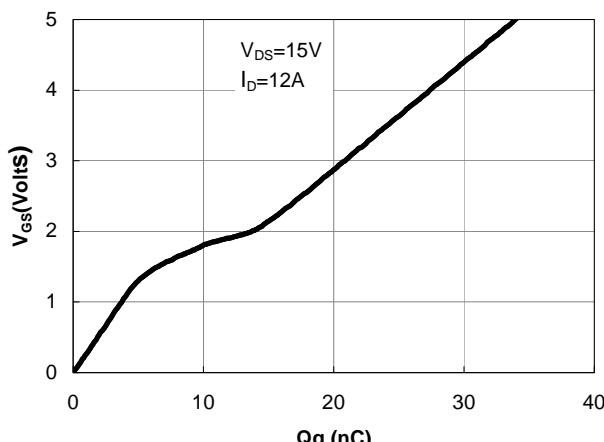
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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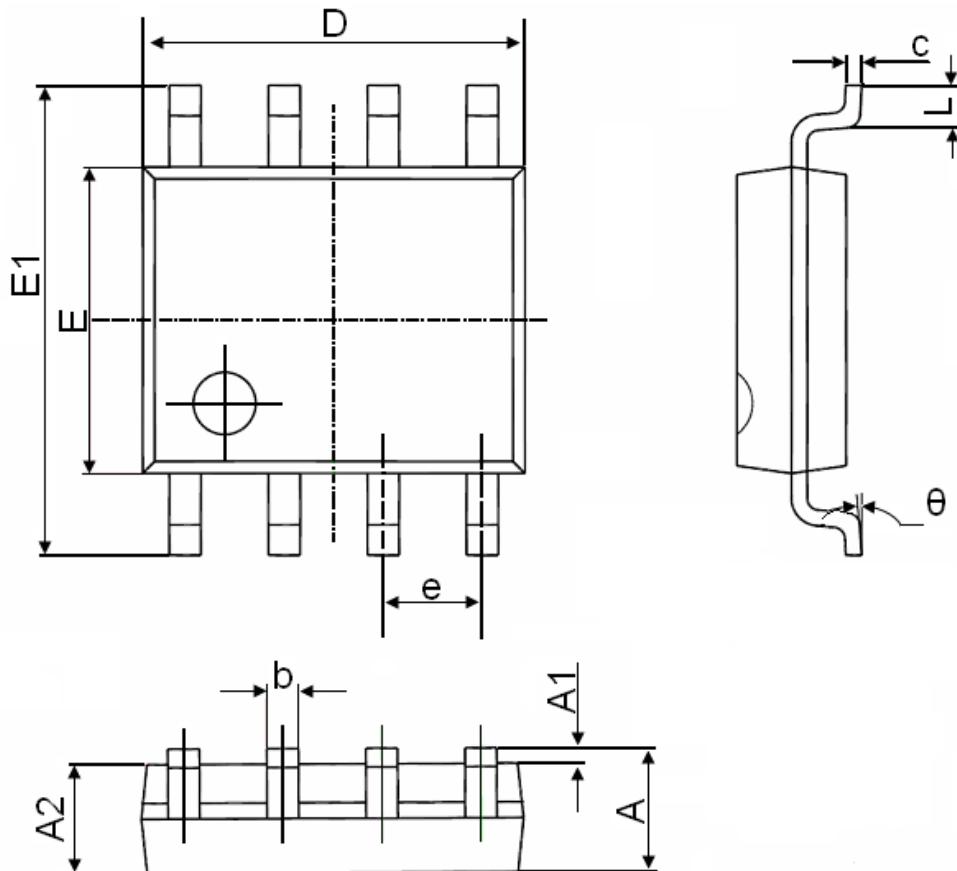
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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SOP-8 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
theta	0°	8°	0°	8°